| Search Notes | | | | |
|--------------|--|--|--|--|
| | | | | |

| Application No. | Applicant(s) | |
|-----------------|--------------|--|
| 09/894,862 | LEE ET AL. | |
| Examiner | Art Unit | |
| Thai O Phan | 2128 | |

| SEARCHED | | | | |
|----------|----------|-----------|----------|--|
| Class | Subclass | Date | Examiner | |
| 703 | 2 | 1/20/2005 | T.P. | |
| 703 | 13 | 1/20/2005 | T.P. | |
| 716 | 5 | 1/20/2005 | T.P. | |
| 716 | 11 | 1/20/2005 | T.P. | |
| 435 | 5 | 1/20/2005 | 7.P. | |
| 435 | 6 | 1/20/2005 | T.P. | |
| 422 | 68.1 | 1/20/2005 | T.P. | |
| 204 | 450 | 1/20/2005 | T.P. | |
| 422 | 98 | 1/20/2005 | T.P. | |
| 422 | 100 | 1/20/2005 | T.P. | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |

| INTERFERENCE SEARCHED | | | | | |
|-----------------------|----------|--------------|----------|--|--|
| Class | Subclass | Date | Examiner | | |
| | | | - | | |
| | | | | | |
| | | - | | | |
| | L | | | | |
| | · | | | | |
| | | | | | |

| SEARCH NO. | |) |
|---------------------------------------|-----------|------|
| | DATE | EXMR |
| USPTO on_line search | 1/20/2005 | T.P. |
| NPL search: IEL, IEEE, ACM | 1/20/2005 | T.P. |
| | | |
| | | |
| · · · · · · · · · · · · · · · · · · · | | |
| | | |
| | , | |
| | | |
| | | |